

Econ 6190: Econometrics I

Hypothesis Testing

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Reference

- Hansen Ch. 13

1. Basic Concepts

Set-up

- A random vector X has distribution $F(x)$
- We are interested in (scalar) parameter θ determined by $F \in \mathcal{F}$
- The parameter space is $\theta \in \Theta$
- We have a random sample $\{X_1, X_2 \dots X_n\}$ from distribution F
- In previous sections, we talked about estimation of θ
- In this section, we are interested in testing some hypothesis about θ

Hypotheses

- A **hypothesis** is a statement about population parameter θ
- We call the hypothesis to be tested the null hypothesis
- **Definition:** The **null hypothesis** \mathbb{H}_0 , is the restriction $\theta = \theta_0$ for some specific value θ_0 , or $\theta \in \Theta_0$ for some subset Θ_0 of Θ . The null hypothesis is often written as

$$\mathbb{H}_0 = \{\theta \in \Theta : \theta = \theta_0\} \text{ or } \mathbb{H}_0 = \{\theta \in \Theta : \theta \in \Theta_0\}$$

- The complement of null hypothesis is alternative hypothesis
- **Definition:** The **alternative hypothesis** is the set

$$\mathbb{H}_1 = \{\theta \in \Theta : \theta \neq \theta_0\} \text{ or } \mathbb{H}_1 = \{\theta \in \Theta : \theta \notin \Theta_0\}$$

Point hypotheses

- In this note, we focus on **point hypothesis**

$$\mathbb{H}_0 = \{\theta \in \Theta : \theta = \theta_0\}$$

- The alternative hypothesis could be
 - one sided: $\mathbb{H}_1 : \theta > \theta_0$ or $\mathbb{H}_1 : \theta < \theta_0$
 - two sided: $\mathbb{H}_1 : \theta \neq \theta_0$
- One sided alternative arises if the null lies on the boundary of the parameter space $\Theta = \{\theta : \theta \geq \theta_0\}$
 - Example: some policy with non-negative effect

- A hypothesis is a restriction on the underlying distribution F
- Define the **null distribution** as a set F_0 such that

$$F_0 = \{F \in \mathcal{F} : \mathbb{H}_0 \text{ is true}\}$$

- F_0 can be a singleton (a single distribution), a parametric family, or a nonparametric family
- Suppose $\mathbb{H}_0 = \{\mu = \mu_0\}$. Examples of F_0
 - singleton: $X \sim N(\mu, \sigma^2)$ with known σ^2
 - parametric: $X \sim N(\mu, \sigma^2)$ with unknown σ^2
 - nonparametric: X has finite mean

Simple vs. composite hypothesis

- **Definition:** A hypothesis \mathbb{H} (could be null or alternative) is **simple** if the set $\{F \in \mathcal{F} : \mathbb{H} \text{ is true}\}$ is a singleton.

A hypothesis \mathbb{H} is **composite** if the set $\{F \in \mathcal{F} : \mathbb{H} \text{ is true}\}$ contains multiple distributions

- Suppose $\mathbb{H}_0 = \{\mu = \mu_0\}$. Examples of F_0
 - singleton: $X \sim N(\mu, \sigma^2)$ with known σ^2
 \Rightarrow simple
 - parametric: $X \sim N(\mu, \sigma^2)$ with unknown σ^2
 \Rightarrow composite
 - nonparametric: X has finite mean
 \Rightarrow composite

Hypothesis test

- Hypothesis test is a decision based on data
- The decision either accepts \mathbb{H}_0 or rejects \mathbb{H}_0 in favor of \mathbb{H}_1
- Procedures of hypothesis testing

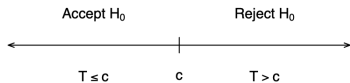
- Construct a real valued function of the data called **test statistic**

$$T = T(X_1, X_2 \dots X_n) \in \mathbb{R}$$

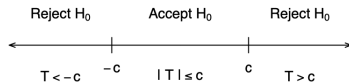
which is a random variable

- Pick a **critical region** C
 - One sided test: $C = \{x : x > c\}$ for **critical value** c
 - Two sided test: $C = \{x : |x| > c\}$ for **critical value** c
 - State hypothesis test as the decision rule

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } T \notin C \\ \text{reject } \mathbb{H}_0 & \text{if } T \in C \end{array}$$



(a) One-Sided Test



(b) Two-Sided Test

Figure: Acceptance and Rejection Regions for Test Statistic

Evaluation of hypothesis test

- A decision could be correct or incorrect
- We evaluate hypothesis tests through their probability of making mistakes
- Two types of errors in hypothesis testing

		Decision	
		Accept H_0	Reject H_0
Truth	H_0	Correct decision	Type I Error
	H_1	Type II Error	Correct decision

Power function

- Power function characterizes probability of making mistakes
- **Definition:** The **power function** of a hypothesis test is the probability of rejection

$$\pi(F) = P\{\text{reject } \mathbb{H}_0 | F\} = P\{T \in C | F\}$$

- **Definition:** The **size** of a hypothesis test is the probability of a Type I error

$$P\{\text{reject } \mathbb{H}_0 | F_0\} = \pi(F_0)$$

for F_0 satisfying \mathbb{H}_0

- **Definition:** The **power** of a hypothesis test is the complement of the probability of a Type II error

$$P\{\text{reject } \mathbb{H}_0 | F_1\} = \pi(F_1) = 1 - P\{\text{accept } \mathbb{H}_0 | \mathbb{H}_1\}$$

for F_1 satisfying \mathbb{H}_1

- Size is power function evaluated at null; Power is power function evaluated at alternative

Type I and II errors can't be reduced simultaneously

- Let $G(x|F) = P\{T \leq x|F\}$ be the sampling distribution of T
 - $G(x|F_0)$ is called **null sampling distribution**
 - $G(x|F_1)$ is called **alternative sampling distribution**
- Consider a one sided test with rejection rule $T > c$
 - Type I error is size $\pi(F_0) = P\{T > c|F_0\} = 1 - G(c|F_0)$
 - Type II error is $1 - \pi(F_1) = P\{T \leq c|F_1\} = G(c|F_1)$
- Since any distribution function $G(x|F)$ is increasing in x
 - Type I error is decreasing in c
 - Type II error is increasing in c

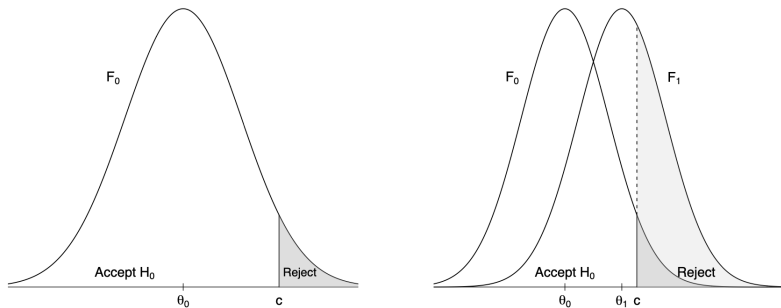


Figure: Left: Null Sampling Distribution for One-Sided Test; Right: Alternative Sampling Distribution for One-Sided Test

2. Classical Approach

Classical approach

- **Control size** and then pick the test to maximize the power subject to this size constraint
- **Definition:** The **significance level** $\alpha \in (0, 1)$ is the probability selected by the researcher to be the maximal acceptable size of the hypothesis test

Classical approach for one sided test

- Consider one sided test

$$\mathbb{H}_0 : \theta = \theta_0, \mathbb{H}_1 : \theta > \theta_0$$

- Given test statistic T , consider the test taking form

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } T \leq c \\ \text{reject } \mathbb{H}_0 & \text{if } T > c \end{array}$$

- Choose c to control size at α

$$\pi(F_0) = P\{T > c|F_0\} = 1 - G(c|F_0) = \alpha \quad (1)$$

- Solving (1) yields

$$c = G^{-1}(1 - \alpha|F_0),$$

the $(1 - \alpha)$ -th quantile of the null sampling distribution

- The test rule

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } T \leq G^{-1}(1 - \alpha|F_0) \\ \text{reject } \mathbb{H}_0 & \text{if } T > G^{-1}(1 - \alpha|F_0) \end{array}$$

has a size equal to α

Classical approach for two sided test

- Consider two sided test

$$\mathbb{H}_0 : \theta = \theta_0, \mathbb{H}_1 : \theta \neq \theta_0$$

with test taking form

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } |T| \leq c \\ \text{reject } \mathbb{H}_0 & \text{if } |T| > c \end{array}$$

- Choose c to control size at α

$$\pi(F_0) = P\{|T| > c | F_0\} = 1 - G(c|F_0) + G(-c|F_0) = \alpha$$

- Suppose $G(x|F_0)$ is symmetric around 0

$$1 - G(c|F_0) + G(-c|F_0) = 2(1 - G(c|F_0)) = \alpha \quad (2)$$

- Solving (2) yields

$$c = G^{-1}(1 - \frac{\alpha}{2}|F_0),$$

the $(1 - \frac{\alpha}{2})$ -th quantile of the null sampling distribution

- The test rule

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } |T| \leq G^{-1}(1 - \frac{\alpha}{2}|F_0) \\ \text{reject } \mathbb{H}_0 & \text{if } |T| > G^{-1}(1 - \frac{\alpha}{2}|F_0) \end{array}$$

has a size equal to α

Example: T Test with normal sampling

- Suppose $X \sim N(\mu, \sigma^2)$ and we wish to test

$$\mathbb{H}_0 : \mu = \mu_0, \quad \mathbb{H}_1 : \mu > \mu_0$$

- Form test statistic

$$T = \frac{\bar{X}_n - \mu_0}{\sqrt{\frac{s^2}{n}}}$$

where \bar{X}_n is sample mean and $s^2 = \frac{1}{n-1} \sum_{i=1}^n (X_i - \bar{X}_n)^2$

- Under \mathbb{H}_0

$$T = \frac{\bar{X}_n - \mu_0}{\sqrt{\frac{s^2}{n}}} \sim t_{n-1}$$

- Given α , set

$$c = q_{1-\alpha}$$

where $q_{1-\alpha}$ is the $1 - \alpha$ -th quantile of t_{n-1} distribution

- A one sided t test with size α is

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } T \leq q_{1-\alpha} \\ \text{reject } \mathbb{H}_0 & \text{if } T > q_{1-\alpha} \end{array}$$

- If σ^2 is **known**, replacing s^2 with σ^2

$$T = \frac{\bar{X}_n - \mu_0}{\sqrt{\frac{\sigma^2}{n}}}$$

yields a z test that uses the quantile of a standard normal

- Analysis of a two sided test is similar

- **Theorem:** In the normal sampling model $X \sim N(\mu, \sigma^2)$, let

$$T = \frac{\bar{X}_n - \mu_0}{\sqrt{\frac{s^2}{n}}}$$

- ① The t test of $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu > \mu_0$ rejects if

$$T > q_{1-\alpha}$$

where $q_{1-\alpha}$ is the $1 - \alpha$ quantile of the t_{n-1} distribution

- ② The t test of $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu < \mu_0$ rejects if

$$T < q_{\alpha}$$

- ③ The t test of $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu \neq \mu_0$ rejects if

$$|T| > q_{1-\alpha/2}$$

These tests have exact size α

Example: Asymptotic T test

- Again suppose X has mean μ and finite variance
- We wish to test

$$\mathbb{H}_0 : \mu = \mu_0, \quad \mathbb{H}_1 : \mu > \mu_0$$

- The t-statistic is

$$T = \frac{\bar{X}_n - \mu_0}{\sqrt{\frac{s^2}{n}}}$$

where s^2 could be replaced by $\hat{\sigma}^2 = \frac{1}{n} \sum_{i=1}^n (X_i - \bar{X}_n)^2$

- Under \mathbb{H}_0 , T is not exactly normal but asymptotically normal by CLT

$$T \xrightarrow{d} N(0, 1)$$

- Thus as $n \rightarrow \infty$

$$\pi(F_0) = P\{T > c | F_0\} \rightarrow P\{N(0, 1) > c\} = 1 - \Phi(c)$$

- **Theorem:** If X has finite mean μ and variance σ^2

- ① The **asymptotic** t test of $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu > \mu_0$ rejects if

$$T > Z_{1-\alpha}$$

where $Z_{1-\alpha}$ is the $1 - \alpha$ quantile of the standard normal distribution

- ② The **asymptotic** t test of $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu < \mu_0$ rejects if

$$T < Z_{\alpha}$$

- ③ The **asymptotic** t test of $\mathbb{H}_0 : \mu = \mu_0$ against $\mathbb{H}_1 : \mu \neq \mu_0$ rejects if

$$|T| > Z_{1-\alpha/2}$$

These tests have **asymptotic** size α

P-value

- Again consider a one sided test

$$\begin{array}{ll} \text{accept } H_0 & \text{if } T \leq c \\ \text{reject } H_0 & \text{if } T > c \end{array}$$

where c is chosen to control size at α

$$P\{T > c | F_0\} = 1 - G(c | F_0) = \alpha$$

- How should we report the results of the test?
 - Method 1: report size α , and decision “Reject H_0 ” or “Accept H_0 ”
 - Method 2: report critical value c and value T at sample points
- Another method: report the value of a certain kind of statistic called **p-value**

- Define **p-value** as

$$p = 1 - G(T|F_0)$$

- Since $G(\cdot|F_0)$ is increasing, p is a decreasing function of T
- Also note

$$\alpha = 1 - G(c|F_0)$$

- Therefore, the decision

reject \mathbb{H}_0 if $T > c$

is equivalent to

reject \mathbb{H}_0 if $p < \alpha$

Method 3: report the value of p

- For each $\alpha \in (0, 1)$

accept \mathbb{H}_0 if $p > \alpha$
reject \mathbb{H}_0 if $p \leq \alpha$

is a size α test

$$\begin{aligned}P\{p \leq \alpha | F_0\} &= P\{1 - G(T|F_0) \leq \alpha | F_0\} \\&= P\{G^{-1}(1 - \alpha | F_0) \leq T | F_0\} \\&= 1 - G(G^{-1}(1 - \alpha | F_0) | F_0) \\&= \alpha\end{aligned}$$

- p is “degree of evidence against \mathbb{H}_0 ”
 - the smaller the p-value, the stronger the evidence against the null
- p is “marginal significance level”
 - the lower bound of the range of size α at which we would reject the null

Further remarks about p-value

- p is a transformation of a statistic rather than a probability
 - It transforms the T statistic to an easily interpretable universal scale between $[0, 1]$
- p allows inference to be continuous rather than dichotomous (more informative)
 - Suppose one statistic has p-value of 0.049 (mildly significant) and the second statistic has the p-value 0.051 (mildly insignificant)
 - From their p value we know these two statistics are essentially the same
 - Reporting “Reject” or “Accept” would not be able to give us such information

2. Power Analysis

Introduction

- So far we focus on the size of the tests
- We know how to construct a test of (asymptotic) size α for mean
- A good test should also have a good power
- It is important to know the power of the test we constructed

Power of T test with known σ^2

- Suppose $X \sim N(\mu, \sigma^2)$ with known σ^2
- Consider statistic

$$T = \frac{\bar{X}_n - \mu_0}{\sqrt{\frac{\sigma^2}{n}}}$$

for tests

$$\mathbb{H}_0 : \mu = \mu_0, \quad \mathbb{H}_1 : \mu > \mu_0$$

- We reject if

$$T = \frac{\bar{X}_n - \mu_0}{\sqrt{\frac{\sigma^2}{n}}} > c$$

where c is chosen to control size at level α

- Whether \mathbb{H}_0 is true or not, $\frac{\bar{X}_n - \mu}{\sqrt{\frac{\sigma^2}{n}}} \sim N(0, 1)$ since \bar{X}_n is centered around true mean μ
- The power function of the test is

$$\begin{aligned}\pi(F) &= P\{T > c|F\} = P\left\{\frac{\bar{X}_n - \mu_0}{\sqrt{\frac{\sigma^2}{n}}} > c|F\right\} \\ &= P\left\{\underbrace{\frac{\bar{X}_n - \mu}{\sqrt{\frac{\sigma^2}{n}}}}_{Z \sim N(0,1)} + \frac{\mu - \mu_0}{\sqrt{\frac{\sigma^2}{n}}} > c|F\right\} \\ &= 1 - \Phi\left(c + \frac{\mu_0 - \mu}{\sqrt{\frac{\sigma^2}{n}}}\right)\end{aligned}$$

- Size is $\pi(F_0) = 1 - \Phi(c)$, since $F_0 = \{F \sim N(\mu, \sigma^2) : \mu = \mu_0\}$
- Power is $\pi(\mu|F_1) = 1 - \Phi\left(c + \frac{\mu_0 - \mu}{\sqrt{\frac{\sigma^2}{n}}}\right)$ where $\mu > \mu_0$
 - Note $\pi(\mu|F_1)$ is increasing in n , μ and decreasing in σ^2 and c

Example: Selection of c and n for power targets

- Suppose now we want to select n and c to achieve size 0.1 and

power at least 0.8 if $\mu \geq \mu_0 + \sigma$

- How should we proceed?
- Step 1: selecting c such that

$$\pi(F_0) = 1 - \Phi(c) = 0.1 \quad (3)$$

ensures size $\alpha = 0.1$. Solving (3) yields $c = 1.28$

- Step 2: since power is increasing in μ , selecting n such that

$$1 - \Phi\left(1.28 + \frac{\mu_0 - \mu}{\sqrt{\frac{\sigma^2}{n}}} \mid \mu = \mu_0 + \sigma\right) \geq 0.8$$

Solving above inequality yields $n \geq 4.49$

- Conclusion: choosing $c = 1.28$ and $n = 5$ yields the desired size and power balance

3. Likelihood Ratio Test

Motivation

- Recall classical approach to testing
 - **Control size** and then pick the test to maximize power subject to this size constraint
- So far we focus on t test
- Another important class of tests is **likelihood ratio test**
 - We show it maximizes power subject to size constraint for testing **simple hypotheses**

Likelihood ratio test for simple hypotheses

- Consider a parametric model $f(x|\theta)$ with likelihood $L_n(\theta) = \prod_{i=1}^n f(X_i|\theta)$
- We want to test simple hypotheses

$$\mathbb{H}_0 : \theta = \theta_0, \quad \mathbb{H}_1 : \theta = \theta_1$$

for some hypothetical values θ_0 and θ_1

- The ratio $\frac{L_n(\theta_1)}{L_n(\theta_0)}$ compares the likelihood function under two hypotheses
- A decision rule could be

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } \frac{L_n(\theta_1)}{L_n(\theta_0)} \leq c \\ \text{reject } \mathbb{H}_0 & \text{if } \frac{L_n(\theta_1)}{L_n(\theta_0)} > c \end{array}$$

for some critical value c

- For convenience, define the **likelihood ratio statistic** as

$$LR_n = 2(\ell_n(\theta_1) - \ell_n(\theta_0))$$

where $\ell_n(\theta) = \log L_n(\theta)$

- A likelihood ratio test is

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } LR_n \leq c \\ \text{reject } \mathbb{H}_0 & \text{if } LR_n > c \end{array}$$

for some critical value c

Example: normal sampling with known variance

- For $X \sim N(\mu, \sigma^2)$ with known σ^2

$$\ell_n(\mu) = -\frac{n}{2} \log(2\pi\sigma^2) - \frac{1}{2\sigma^2} \sum_{i=1}^n (X_i - \mu)^2$$

- Suppose

$$\mathbb{H}_0 : \mu = \mu_0, \quad \mathbb{H}_1 : \mu = \mu_1 > \mu_0$$

$$\begin{aligned} LR_n &= \frac{1}{\sigma^2} \sum_{i=1}^n ((X_i - \mu_0)^2 - (X_i - \mu_1)^2) \\ &= \frac{n}{\sigma^2} [2\bar{X}_n(\mu_1 - \mu_0) + (\mu_0^2 - \mu_1^2)] \end{aligned}$$

- Rejecting \mathbb{H}_0 for some $LR_n > c$ is equivalent to rejecting if

$$T = \frac{\bar{X}_n - \mu_0}{\frac{\sigma}{\sqrt{n}}} > \text{some constant}$$

Neyman-Pearson Lemma

- **Theorem:** Suppose random variable X has a parametric pdf/pmf $f(X|\theta)$. Among all tests of a simple null hypothesis against a simple alternative hypothesis

$$\mathbb{H}_0 : \theta = \theta_0, \mathbb{H}_1 : \theta = \theta_1$$

with size α , the likelihood ratio test has the greatest power.

- In the normal sampling model with known variance, the likelihood ratio test of simple hypotheses is identical to a t test using a known variance
- By Neyman-Pearson Lemma, t test using a known variance is the most powerful test for this hypothesis in this model

Proof

- Consider likelihood ratio test

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } \frac{L_n(\theta_1)}{L_n(\theta_0)} \leq c \\ \text{reject } \mathbb{H}_0 & \text{if } \frac{L_n(\theta_1)}{L_n(\theta_0)} > c \end{array}$$

where c is chosen such that

$$P \left\{ \frac{L_n(\theta_1)}{L_n(\theta_0)} > c \mid \theta = \theta_0 \right\} = \alpha$$

- Let the joint density of observations be $f(\mathbf{x}|\theta)$ for some $\mathbf{x} = (x_1, \dots, x_n)'$
- Then $L_n(\theta) = f(\mathbf{X}|\theta)$, where $\mathbf{X} = (X_1, \dots, X_n)$

- Since test is binary decision (accept/reject), it can be represented by binary function (called test function)
- The likelihood ratio test function is

$$\psi_{LR} = \mathbf{1} \{f(\mathbf{X}|\theta_1) > cf(\mathbf{X}|\theta_0)\}$$

that is, $\psi_{LR} = 1$ if likelihood ratio rejects \mathbb{H}_0 and $\psi_{LR} = 0$ otherwise

- Let ψ_a be any alternative test function with same size α
- Since both tests have same size

$$P \{ \psi_{LR} = 1 | \theta = \theta_0 \} = P \{ \psi_a = 1 | \theta = \theta_0 \} = \alpha$$

or equivalently

$$\int \psi_{LR} f(\mathbf{x}|\theta_0) d\mathbf{x} = \int \psi_a f(\mathbf{x}|\theta_0) d\mathbf{x} = \alpha$$

- The power of likelihood ratio test is

$$\begin{aligned}
 & P \left\{ \frac{L_n(\theta_1)}{L_n(\theta_0)} > c \mid \theta = \theta_1 \right\} \\
 &= P \{ \psi_{LR} = 1 \mid \theta = \theta_1 \} \\
 &= \int \psi_{LR} f(\mathbf{x} \mid \theta_1) d\mathbf{x} \\
 &= \int \psi_{LR} f(\mathbf{x} \mid \theta_1) d\mathbf{x} - c \left\{ \int \psi_{LR} f(\mathbf{x} \mid \theta_0) d\mathbf{x} - \int \psi_a f(\mathbf{x} \mid \theta_0) d\mathbf{x} \right\} \\
 &= \int \psi_{LR} (f(\mathbf{x} \mid \theta_1) - cf(\mathbf{x} \mid \theta_0)) d\mathbf{x} + c \int \psi_a f(\mathbf{x} \mid \theta_0) d\mathbf{x} \\
 &\geq \int \psi_a (f(\mathbf{x} \mid \theta_1) - cf(\mathbf{x} \mid \theta_0)) d\mathbf{x} + c \int \psi_a f(\mathbf{x} \mid \theta_0) d\mathbf{x} \\
 &= \int \psi_a f(\mathbf{x} \mid \theta_1) d\mathbf{x} \\
 &= \text{power of } \psi_a
 \end{aligned}$$

- The inequality holds since
 - if $(f(\mathbf{x}|\theta_1) - cf(\mathbf{x}|\theta_0)) > 0$, $\psi_{LR} = 1$, and

$$\psi_{LR}(f(\mathbf{x}|\theta_1) - cf(\mathbf{x}|\theta_0)) \geq \psi_a(f(\mathbf{x}|\theta_1) - cf(\mathbf{x}|\theta_0))$$

- if $(f(\mathbf{x}|\theta_1) - cf(\mathbf{x}|\theta_0)) \leq 0$, $\psi_{LR} = 0$

$$\psi_{LR}(f(\mathbf{x}|\theta_1) - cf(\mathbf{x}|\theta_0)) = 0 \geq \psi_a(f(\mathbf{x}|\theta_1) - cf(\mathbf{x}|\theta_0))$$

- Hence the power of the likelihood ratio test is greater than the power of the test ψ_a
- By the arbitrariness of ψ_a , we conclude likelihood ratio test has higher power than any other test with the same size

Likelihood Ratio Test against composite alternatives

- Consider **two sided test**

$$\mathbb{H}_0 : \theta = \theta_0, \mathbb{H}_1 : \theta \neq \theta_0$$

- The log likelihood under \mathbb{H}_1 is the unrestricted maximum of the likelihood
- Let $\hat{\theta}$ be the MLE that maximizes $L_n(\theta)$
- The likelihood ratio statistic is

$$LR_n = 2 \left(\ell_n(\hat{\theta}) - \ell_n(\theta_0) \right)$$

- The likelihood ratio test is

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } LR_n \leq c \\ \text{reject } \mathbb{H}_0 & \text{if } LR_n > c \end{array}$$

for some critical value c

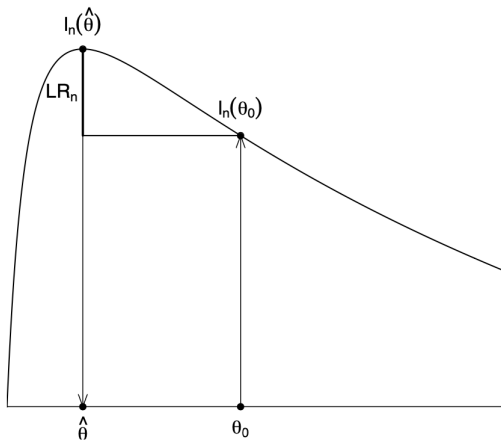


Figure: Likelihood Ratio

- Consider **one sided test**

$$\mathbb{H}_0 : \theta = \theta_0, \mathbb{H}_1 : \theta > \theta_0$$

- The log likelihood under \mathbb{H}_1 is the maximum of the log likelihood in the restricted set

$$\{\theta : \theta \geq \theta_0\},$$

that is, $\ell_n(\hat{\theta}^+)$, where $\hat{\theta}^+ = \arg \max_{\theta \geq \theta_0} \ell_n(\theta)$

- The likelihood ratio statistic is

$$LR_n^+ = 2 \left(\ell_n(\hat{\theta}^+) - \ell_n(\theta_0) \right)$$

- The likelihood ratio test is

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } LR_n^+ \leq c \\ \text{reject } \mathbb{H}_0 & \text{if } LR_n^+ > c \end{array}$$

for some critical value c

Example: Normal sampling with known variance

- Again suppose $X \sim N(\mu, \sigma^2)$ with σ^2 known
- Consider testing

$$\mathbb{H}_0 : \mu = \mu_0, \mathbb{H}_1 : \mu > \mu_0$$

- We've shown that for simple hypothesis

$$\mathbb{H}_0 : \mu = \mu_0, \mathbb{H}_1 : \mu = \mu_1 > \mu_0$$

likelihood ratio test is equivalent to a t test

$$\text{rejecting } H_0 \text{ if } \frac{\bar{X}_n - \mu_0}{\frac{\sigma}{\sqrt{n}}} > b, \text{ for some } b$$

- Such analysis does not depend on specific value of μ_1
- Thus this t test is also the likelihood ratio test for one-sided alternative

Asymptotic size control for Likelihood Ratio Test

- **Theorem:** For simple null hypotheses, under $\mathbb{H}_0 : \theta = \theta_0$

$$LR_n \xrightarrow{d} \chi^2_{\dim(\theta)}$$

Let $q_{1-\alpha}$ be the $1 - \alpha$ -th quantile of $\chi^2_{\dim(\theta)}$. The test

$$\begin{array}{ll} \text{accept } \mathbb{H}_0 & \text{if } LR_n \leq q_{1-\alpha} \\ \text{reject } \mathbb{H}_0 & \text{if } LR_n > q_{1-\alpha} \end{array}$$

has asymptotic size α

- Moreover, likelihood ratio and t tests are **asymptotically** equivalent tests

Sketch proof

- Note $LR_n = 2 \left(\ell_n(\hat{\theta}) - \ell_n(\theta_0) \right)$
- Second order Taylor expansion yields

$$\ell_n(\theta_0) \simeq \ell_n(\hat{\theta}) + \underbrace{\frac{\partial}{\partial \theta} \ell_n(\hat{\theta})'}_{\mathbf{0}} (\hat{\theta} - \theta_0) + \frac{1}{2} (\hat{\theta} - \theta_0)' \underbrace{\frac{\partial^2}{\partial \theta \partial \theta} \ell_n(\hat{\theta})}_{-\hat{V}^{-1}} (\hat{\theta} - \theta_0)$$

- Note where $\hat{V} = \left\{ -\frac{\partial^2}{\partial \theta \partial \theta} \ell_n(\hat{\theta}) \right\}^{-1}$ is the Hessian estimator of the asymptotic variance of $\hat{\theta}$ estimated Hessian
- Hence

$$2 \left(\ell_n(\hat{\theta}) - \ell_n(\theta_0) \right) \simeq (\hat{\theta} - \theta_0)' \hat{V}^{-1} (\hat{\theta} - \theta_0)$$

- As $n \rightarrow \infty$, the RHS converges to $\chi_{\dim(\theta)}^2$